

## **STW63N65DM2**

# N-channel 650 V, 0.042 Ω typ., 60 A MDmesh™ DM2 Power MOSFET in a TO-247 package

Datasheet - production data

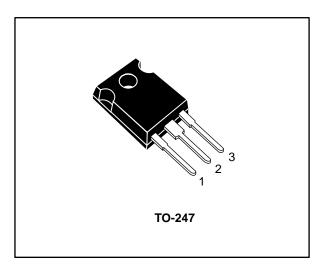
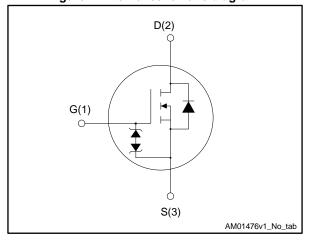


Figure 1: Internal schematic diagram



### **Features**

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>	P <sub>TOT</sub>
STW63N65DM2	650 V	0.05 Ω	60 A	446 W

- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

### **Applications**

• Switching applications

## Description

This high-voltage N-channel Power MOSFET is part of the MDmesh™ DM2 fast recovery diode series. It offers very low recovery charge (Q<sub>rr</sub>) and time (t<sub>rr</sub>) combined with low R<sub>DS(on)</sub>, rendering it suitable for the most demanding high-efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

**Table 1: Device summary** 

Order code	Marking	Package	Packing
STW63N65DM2	63N65DM2	TO-247	Tube

Contents STW63N65DM2

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STW63N65DM2 Electrical ratings

# 1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit	
V <sub>G</sub> s	Gate-source voltage	±25	V	
1_	Drain current (continuous) at T <sub>case</sub> = 25 °C	60	۸	
ID	Drain current (continuous) at T <sub>case</sub> = 100 °C		A	
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	240	Α	
P <sub>TOT</sub>	Total dissipation at T <sub>case</sub> = 25 °C	446	W	
dv/dt <sup>(2)</sup>	Peak diode recovery voltage slope	50	V/ns	
dv/dt <sup>(3)</sup>	MOSFET dv/dt ruggedness		V/IIS	
T <sub>stg</sub>	Storage temperature range	EE to 150	°C	
Tj	Operating junction temperature range	-55 to 150	C	

#### Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case		٥٥٨٨
R <sub>thj-amb</sub>	Thermal resistance junction-ambient		°C/W

**Table 4: Avalanche characteristics** 

Symbol	Parameter	Value	Unit
I <sub>AR</sub>	Avalanche current, repetitive or non-repetitive	8	Α
E <sub>AS</sub> <sup>(1)</sup>	Single pulse avalanche energy	1100	mJ

### Notes:

 $^{(1)}Starting~T_{j}=25~^{\circ}C,~I_{D}=I_{AR},~V_{DD}=50~V.$ 

<sup>&</sup>lt;sup>(1)</sup>Pulse width is limited by safe operating area.

 $<sup>^{(2)}</sup>I_{SD} \leq 60$  A, di/dt=800 A/ $\mu$ s, V $_{DS}$  peak < V $_{(BR)DSS}$ , V $_{DD}$  = 80% V $_{(BR)DSS}$ 

 $<sup>^{(3)}</sup>V_{DS} \le 520 \text{ V}$ 

## 2 Electrical characteristics

(T<sub>case</sub> = 25 °C unless otherwise specified)

Table 5: Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA	650			٧
	Zoro goto voltago droin	$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V}$			10	
IDSS	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V},$ $T_{case} = 125 \text{ °C}^{(1)}$			100	μΑ
Igss	Gate-body leakage current	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±25 V			±5	μΑ
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	3	4	5	V
R <sub>DS(on)</sub>	Static drain-source on-resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 30 A		0.042	0.05	Ω

#### Notes:

Table 6: Dynamic

Symbol	Parameter	meter Test conditions		Тур.	Max.	Unit
Ciss	Input capacitance		-	5500	ı	
Coss	Output capacitance	V <sub>DS</sub> = 100 V, f = 1 MHz,	-	210	ı	pF
C <sub>rss</sub>	Reverse transfer capacitance	$V_{GS} = 0 V$	-	3	ı	ρı
Coss eq. (1)	Equivalent output capacitance	V <sub>DS</sub> = 0 to 520 V, V <sub>GS</sub> = 0 V	-	456	1	pF
R <sub>G</sub>	Intrinsic gate resistance	f = 1 MHz, I <sub>D</sub> = 0 A	-	3.3	•	Ω
Qg	Total gate charge	$V_{DD} = 520 \text{ V}, I_{D} = 60 \text{ A},$	-	120	•	
$Q_{gs}$	Gate-source charge	V <sub>GS</sub> = 0 to 10 V (see Figure 15: "Test circuit for	-	27	-	nC
$Q_gd$	Gate-drain charge	gate charge behavior")	-	58	-	

#### Notes:

Table 7: Switching times

<b>_</b>						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time	V <sub>DD</sub> = 325 V, I <sub>D</sub> = 30 A	-	33	1	
tr	Rise time	$R_G = 4.7 \Omega$ , $V_{GS} = 10 V$ (see Figure 14: "Test circuit for	-	13.5	ı	
t <sub>d(off)</sub>	Turn-off delay time	resistive load switching times"	-	114	ı	ns
t <sub>f</sub>	Fall time	and Figure 19: "Switching time waveform")	-	11.5	-	



<sup>&</sup>lt;sup>(1)</sup>Defined by design, not subject to production test.

 $<sup>^{(1)}</sup>$  C<sub>oss eq.</sub> is defined as a constant equivalent capacitance giving the same charging time as C<sub>oss</sub> when V<sub>DS</sub> increases from 0 to 80% V<sub>DSS</sub>.

Table 8: Source-drain diode

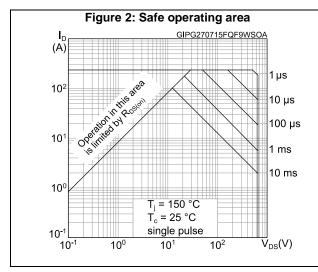
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Isp	Source-drain current		-		60	Α
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		240	Α
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 60 A	ı		1.6	<b>V</b>
t <sub>rr</sub>	Reverse recovery time	$I_{SD} = 60 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	ı	154		ns
Qrr	Reverse recovery charge	V <sub>DD</sub> = 60 V (see Figure 16: "Test circuit for	-	0.94		μC
I <sub>RRM</sub>	Reverse recovery current	inductive load switching and diode recovery times")	1	12.2		А
t <sub>rr</sub>	Reverse recovery time	$I_{SD} = 60 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	ı	288		ns
Qrr	Reverse recovery charge	$V_{DD} = 60 \text{ V}, T_j = 150 ^{\circ}\text{C}$ (see Figure 16: "Test circuit for	-	3.65		μC
I <sub>RRM</sub>	Reverse recovery current	inductive load switching and diode recovery times")	-	25.4		Α

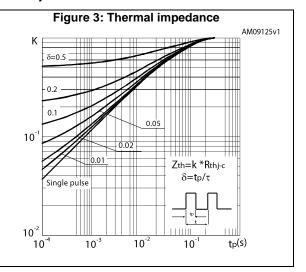
#### Notes:

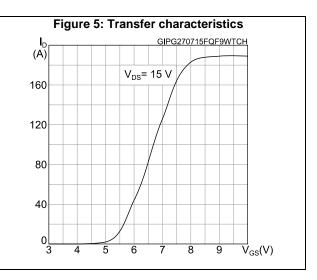
<sup>&</sup>lt;sup>(1)</sup>Pulse width is limited by safe operating area.

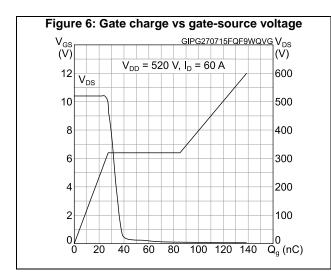
 $<sup>^{(2)}\</sup>text{Pulse}$  test: pulse duration = 300  $\mu\text{s},$  duty cycle 1.5%

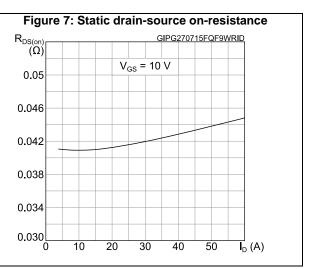
## 2.1 Electrical characteristics (curves)











STW63N65DM2 Electrical characteristics

Figure 8: Capacitance variations C (pF) GIPG270715FQF9WCVR 10<sup>4</sup> C<sub>ISS</sub>  $10^{3}$ Coss 10<sup>2</sup> f = 1 MHz 10<sup>1</sup> C<sub>RSS</sub> 10<sup>0</sup>  $\overline{V}_{DS}(V)$ 10<sup>-1</sup> 10<sup>0</sup> 10<sup>1</sup> 10<sup>2</sup>

Figure 9: Normalized gate threshold voltage vs temperature V<sub>GS(th)</sub> (norm.) GIPG270715FQF9WVTH  $I_D = 250 \, \mu A$ 1.1 1.0 0.9 0.8 0.7 0.6 -75 25 75 T<sub>i</sub> (°C) -25 125

Figure 10: Normalized on-resistance vs temperature

R<sub>DS(on)</sub> GIPG270715FQF9WRON
(norm.)

2.2

1.8

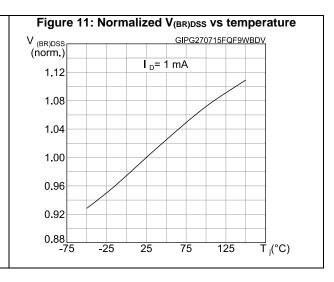
1.4

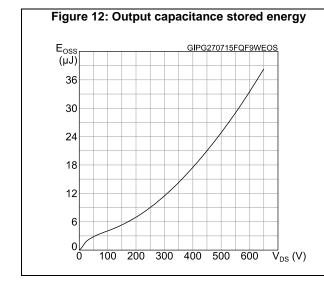
1.0

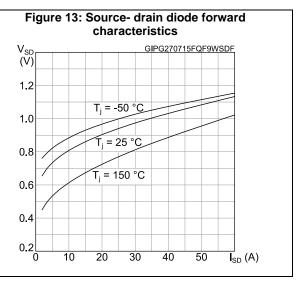
0.6

0.2

-75 -25 25 75 125 T<sub>j</sub> (°C)







Test circuits STW63N65DM2

### 3 Test circuits

Figure 14: Test circuit for resistive load switching times

Proposition of the switching times

Proposition of the switching times

AM01488v1

Figure 15: Test circuit for gate charge behavior

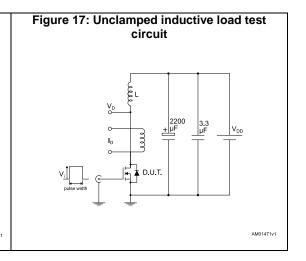
12 V 47 kΩ 100 nF 1 kΩ

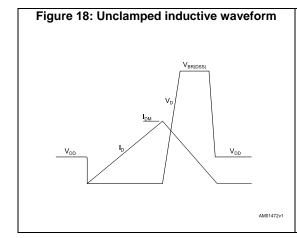
Vos 1 kΩ 1 kΩ

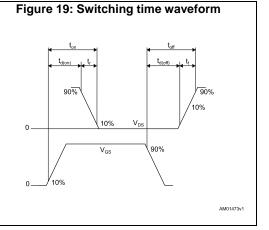
Vos 1 kΩ 1 kΩ

AM01466y1

Figure 16: Test circuit for inductive load switching and diode recovery times







# 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

## 4.1 TO-247 package information

HEAT-SINK PLANE S øR Ľ2 *b1 b2* BACK VIEW 0075325\_8

Figure 20: TO-247 package outline

Table 9: TO-247 package mechanical data

Dim	•	mm	
Dim.	Min.	Тур.	Max.
А	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
С	0.40		0.80
D	19.85		20.15
E	15.45		15.75
е	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

STW63N65DM2 Revision history

# 5 Revision history

Table 10: Document revision history

Date	Revision	Changes
05-May-2017	1	Initial release

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